



Schedule of Scope to Certificate of Conformity Approved Process

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In respect of standards and specifications:

IEC 60747-1:2006

Semiconductor devices - Part 1: General

IEC 60748-1:2002

Semiconductor devices - Integrated circuits - Part 1: General

ISO 9001:2015

Quality management systems - Requirements

Component:

Semiconductor devices and Integrated circuits

Scope:

The purchase, manufacture and test of Semiconductor devices and Integrated circuits.

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